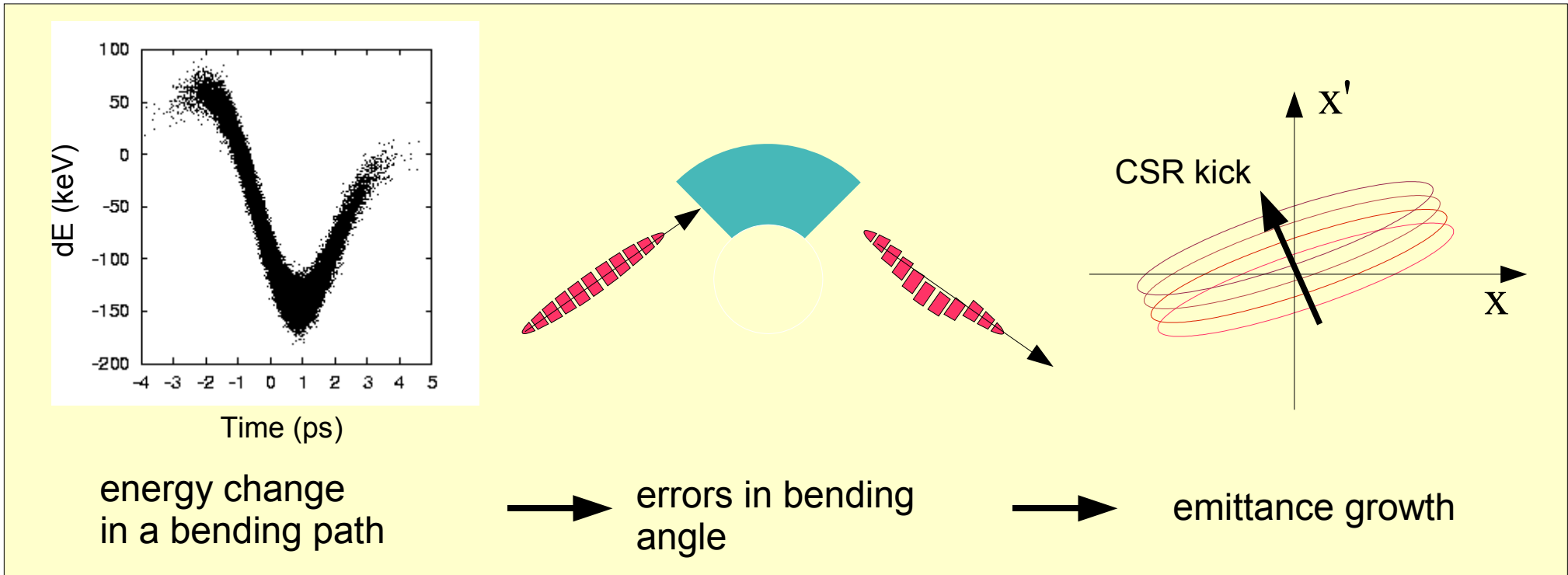

Matrix analysis for the effects of CSR and longitudinal space charge force in an ERL

R. Hajima (JAERI)

Emittance Growth due to the Coherent Synchrotron Radiation (CSR)



$$\Delta E_{ave} = -0.3505 \frac{r_e Q L_b}{e \gamma (R^2 \sigma_s^4)^{1/3}} \quad \text{--- critical for a short bunch}$$

Many studies on bunch compressors for SASE-FELs, experiments and simulations

For ERL light sources (femtoseconds, $\epsilon_n \leq 1$ mm-mrad)

CSR is one of the sources of emittance growth.

Linear Analysis of the CSR Effect on the Transverse Beam Dynamics

1st-order analysis

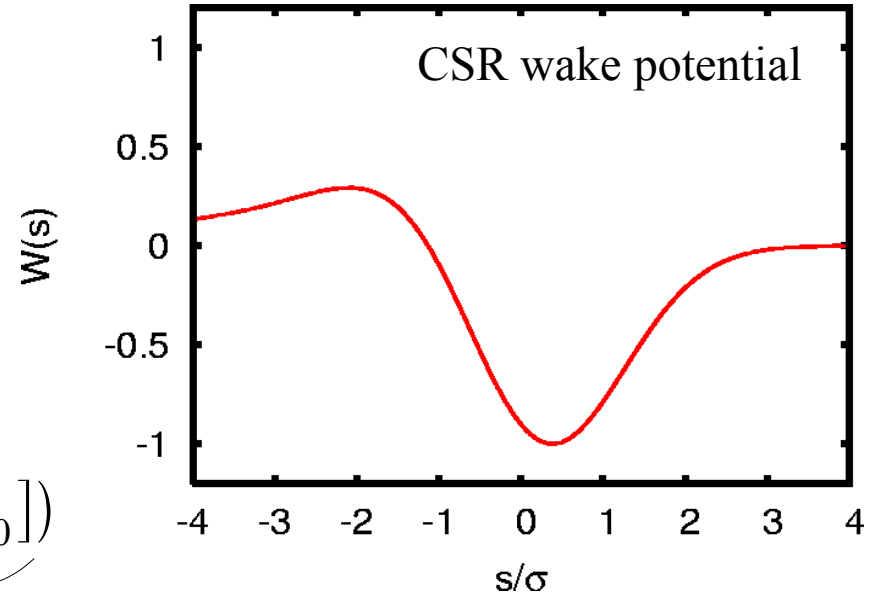
$$\frac{x}{\rho} \ll 1 \quad \text{and} \quad \frac{\Delta P_{CSR}}{P_0} \ll 1$$

electron's motion in a bending plane

$$x'' = -\frac{x}{\rho^2} + \frac{1}{\rho} \underbrace{(\delta_0 + \delta_{CSR} + \kappa [s - s_0])}_{\text{for CSR}}$$

x deviation from the reference path
 ρ curvature radius of the bending
 δ_0 initial momentum error

s coordinate along the path
 κ normalized CSR wake potential
 δ_{CSR} momentum error by CSR in the upstream path



We assume

- all the dipoles have the same bending radius,
- the bunch does not change its longitudinal profile,
- the transient CSR effect is not large.



constant CSR wake regime,
valid for GeV ERLs

we can attribute κ
to each electron

5x5 R-Matrix for the CSR Analysis

electron's motion in the bending plane is expressed by a vector

$$\vec{x}(s) = (x, x', \delta_0, \kappa L_b, \kappa)^T$$

$$\delta_{CSR}(s) = \kappa \underline{L_b}(s)$$



sum of bending path length in the upstream

before the bend

$$\vec{x}(s_0) = (x, x', \delta_0, \kappa L_b, \kappa)^T$$

after the bend

$$\vec{x}(s_1) = (x, x', \delta_0, \kappa L_b, \kappa)^T$$

transfer matrix of the bend

$$\vec{x}(s_1) = R_{bend} \vec{x}(s_0)$$

5x5 R-matrix for a sector bending magnet

$$R_{bend} = \begin{pmatrix} \cos \theta & \rho \sin \theta & \rho(1 - \cos \theta) & \rho(1 - \cos \theta) & \rho^2(\theta - \sin \theta) \\ -\rho^{-1} \sin \theta & \cos \theta & \sin \theta & \sin \theta & \rho(1 - \cos \theta) \\ 0 & 0 & 1 & 0 & 0 \\ 0 & 0 & 0 & 1 & \rho \theta \\ 0 & 0 & 0 & 0 & 1 \end{pmatrix}$$

extension of the conventional 3x3 R-matrix

R. Hajima, JJAP 42, L974 (2003).

CSR-wake dispersion function

Following the momentum dispersion function “ η ”, we define the CSR wake dispersion function “ ζ ”

momentum dispersion function

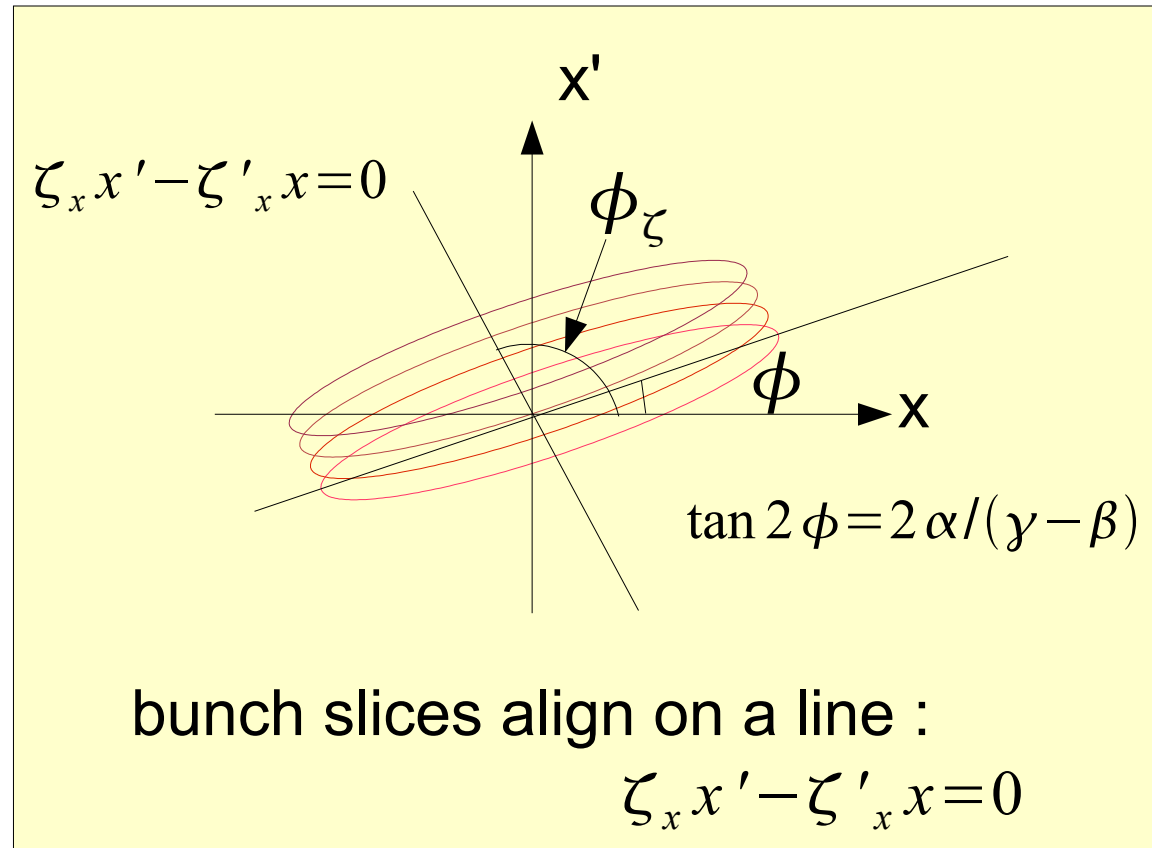
(η, η')

$$\begin{pmatrix} \eta_x(s_1) \\ \eta'_x(s_1) \\ 1 \\ 0 \\ 0 \end{pmatrix} = R_{0 \rightarrow 1} \begin{pmatrix} \eta_x(s_0) \\ \eta'_x(s_0) \\ 1 \\ 0 \\ 0 \end{pmatrix}$$

CSR wake dispersion function

(ζ, ζ')

$$\begin{pmatrix} \zeta_x(s_1) \\ \zeta'_x(s_1) \\ 0 \\ L_b(s_1) \\ 1 \end{pmatrix} = R_{0 \rightarrow 1} \begin{pmatrix} \zeta_x(s_0) \\ \zeta'_x(s_0) \\ 0 \\ L_b(s_0) \\ 1 \end{pmatrix}$$



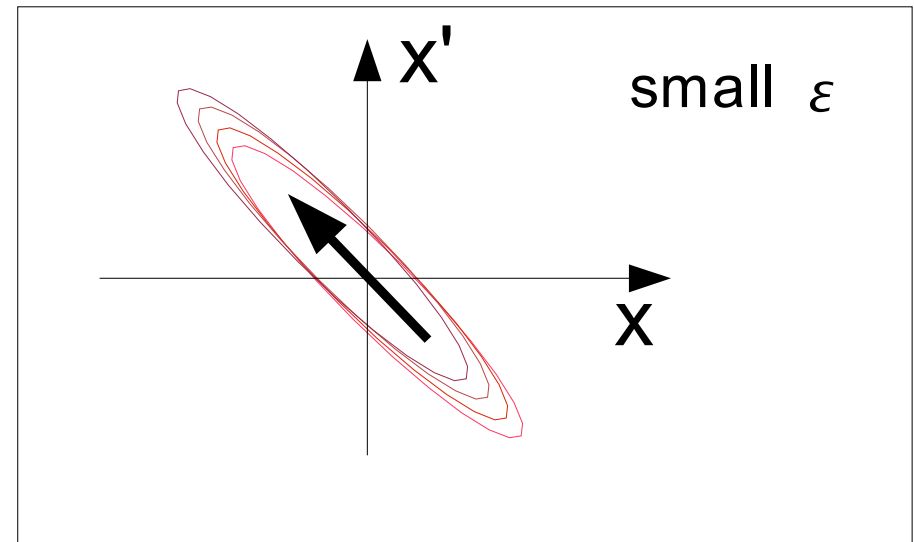
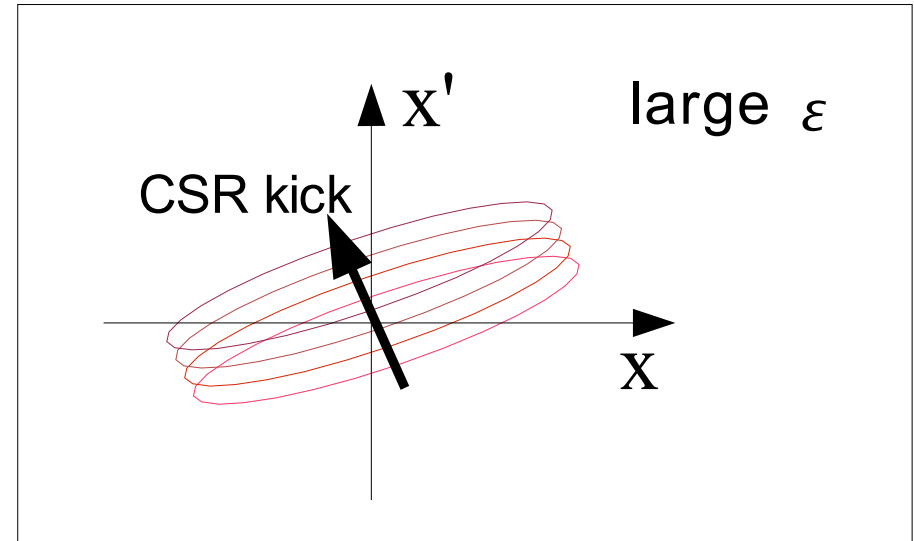
We can track the motion of bunch slices.

Emittance Growth by CSR, and its Compensation

coincidence between the CSR kick and the phase ellipse orientation.



minimum emittance growth



projection emittance is evaluated by

$$\varepsilon^2 = (\varepsilon_0 \beta_x + D^2)(\varepsilon_0 \gamma_x + D'^2) - (-\varepsilon_0 \alpha_x + D D')^2$$

$$(D, D') = \Delta \kappa_{rms} (\zeta_x, \zeta_x')$$

$$\Delta \kappa_{rms} = \frac{\Delta E_{rms}}{E_0 L_b}$$

$$\varepsilon^2 - \varepsilon_0^2 = \varepsilon_0 \frac{(\Delta \kappa_{rms})^2 (\beta_x \zeta'^2 + \gamma_x \zeta^2 - 2\alpha_x \zeta \zeta')}{\zeta^2}$$

bunch parameter

beam transport

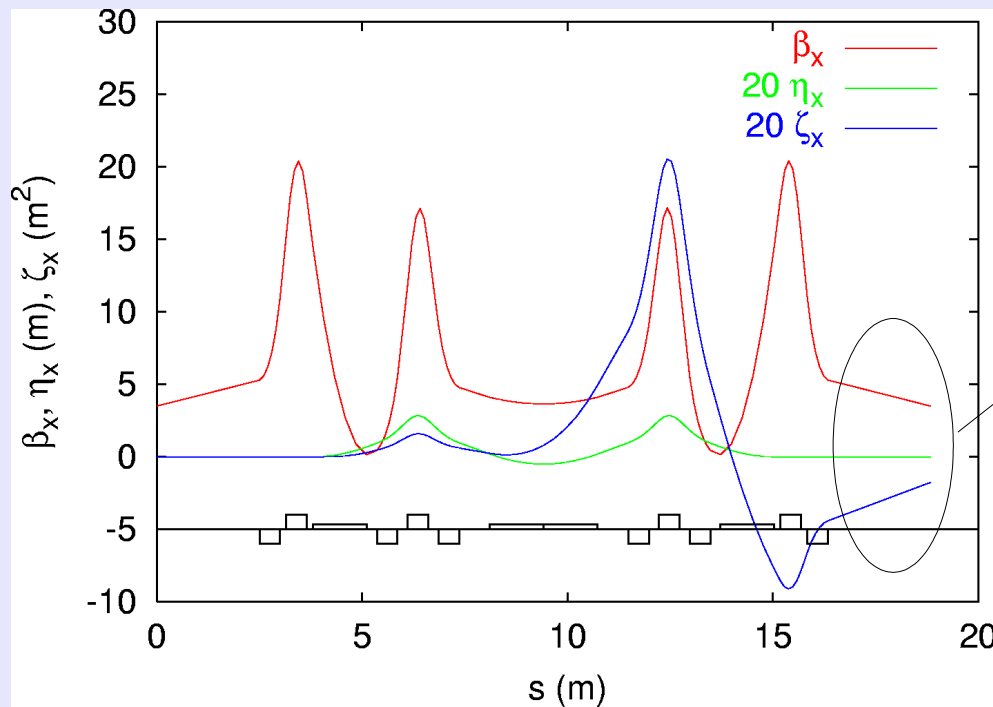
Optimization of a 3-GeV ERL



Triple Bend Achromat

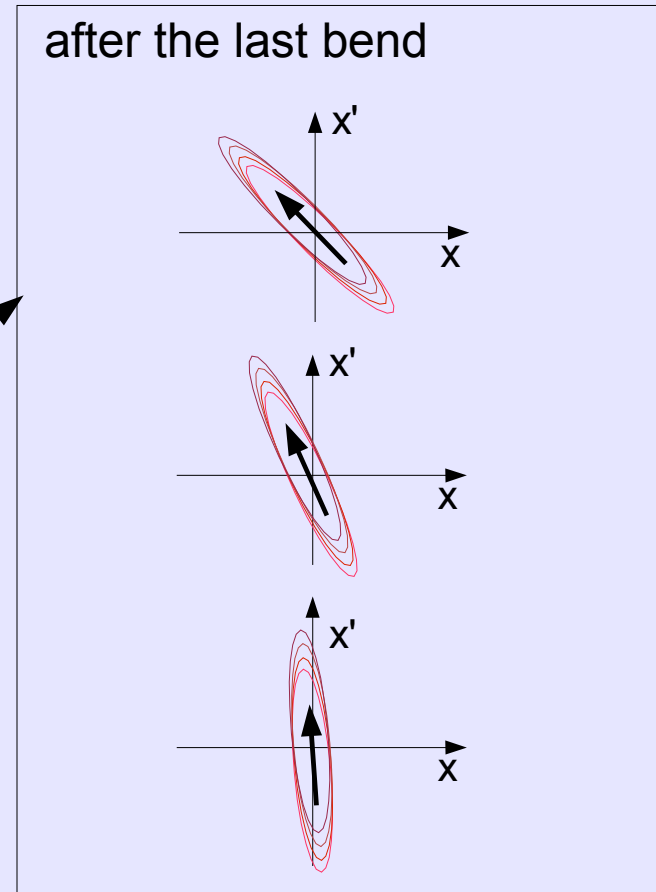
$$\rho = 25 \text{ m}, \theta = 3 + 6 + 3 = 12 \text{ deg.}$$

design for minimum emittance growth



β_x and ζ_x have the same envelope after the last bend
-- envelope matching

after the last bend



- R-matrix analysis gives the optimum design.
- This analysis is independent of beam parameters, charge, bunch length,

Comparison with Particle Simulations

Designed TBA cell and

bunch parameters

$$E_0 = 3.07 \text{ GeV}$$

$$\sigma_s = 30 \mu\text{m} (100\text{fs})$$

$$Q = 770 \text{ pC}$$

$$\varepsilon_{n,0} = 0.1 \text{ mm-mrad}$$

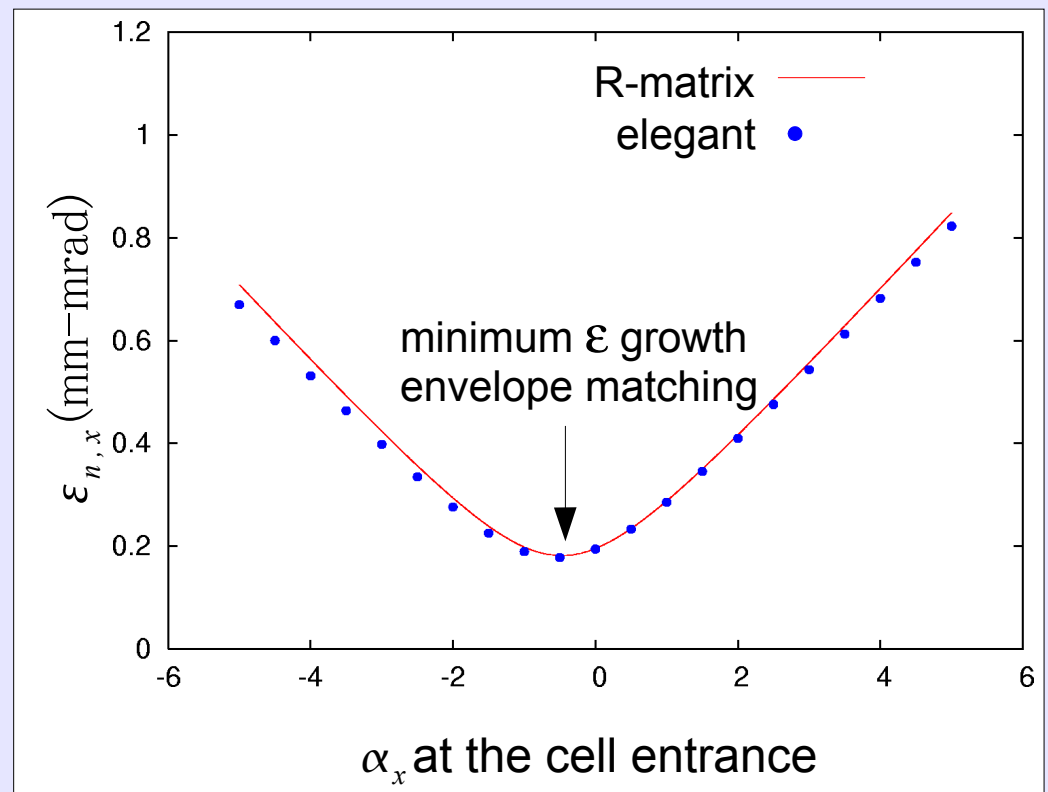
calculation of emittance
with scanning beam envelope

$$-5 < \alpha_x < 5, \gamma_x = 0.29 \text{ m}^{-1}$$

(at the cell entrance)

comparison with
a simulation code elegant*

* M.Borland, PR-STAB 4, 070701(2001)

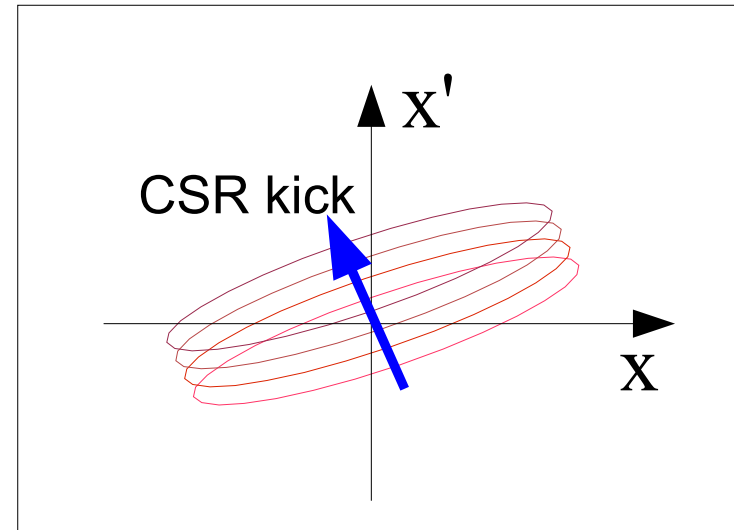


■ R-Matrix method gives an optimum design and predicts the emittance growth.

Emittance Growth by Shielded CSR

projection emittance is evaluated by

$$\varepsilon^2 - \varepsilon_0^2 = \varepsilon_0 (\Delta \kappa_{rms})^2 (\beta_x \zeta'^2 + \gamma_x \zeta^2 - 2\alpha_x \zeta \zeta')$$



emittance is a function of CSR wake dispersion and "beam energy-spread" caused by CSR.

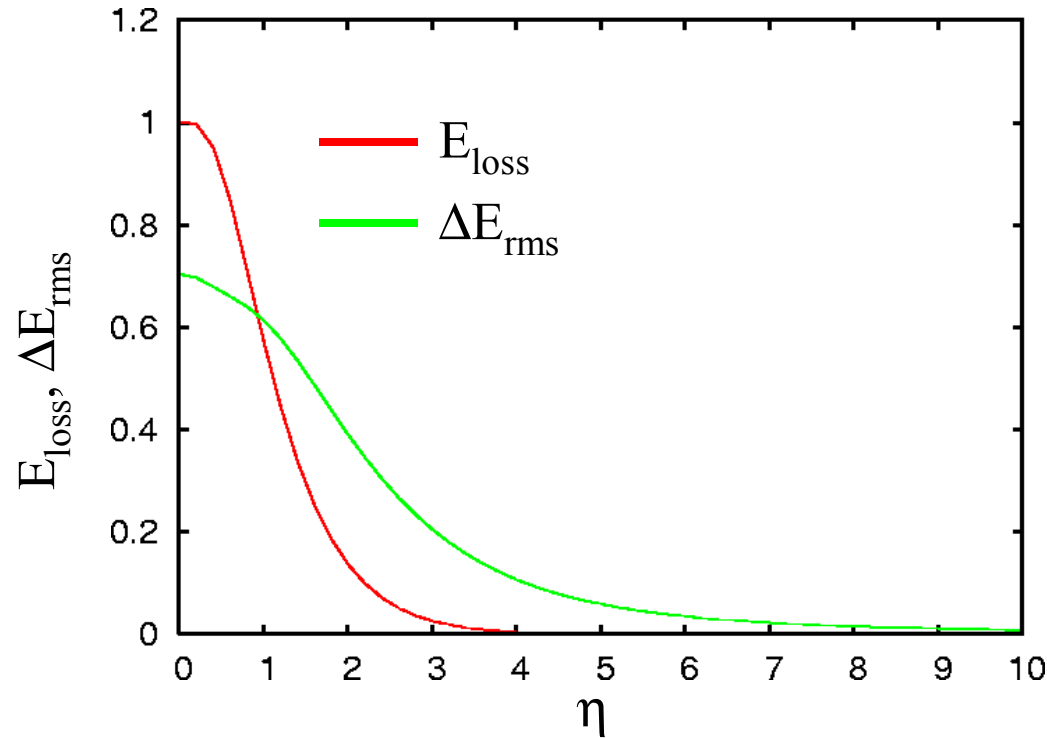
CSR wake dispersion : determined by beam transport geometry

beam energy spread: determined by bunch parameters and shielding.

shielded CSR is given by impedance analysis.

T. Agoh, K. Yokoya, PRST-AB 7, 054403 (2004).
 R.L. Warnock, SLAC-PUB-5375 (1990)

Energy Loss, Energy Spread by Shielded CSR



shielding parameter

$$\eta = \sqrt{2/3} \left(\frac{\pi \rho}{h} \right)^{3/2} \left(\frac{\sigma_s}{\rho} \right)$$

ρ : bending radius

h : full gap of two parallel plates

σ_s : RMS bunch length

strong shielding

$$\rho = 25\text{m}, h = 2\text{cm}, \sigma_s = 900 \mu\text{m} (3\text{ps}) \rightarrow \eta = 7.2$$

$$\frac{P_{CSR}(\text{shielded})}{P_{CSR}(\text{free space})} = \frac{E_{loss}(\text{shielded})}{E_{loss}(\text{free space})} = 1.2 \times 10^{-5}$$

$$\frac{\Delta \varepsilon(\text{shielded})}{\Delta \varepsilon(\text{free space})} = \frac{\Delta E_{rms}(\text{shielded})}{\Delta E_{rms}(\text{free space})} = 0.029$$

we define: $\Delta \varepsilon = \sqrt{(\varepsilon^2 - \varepsilon_0^2)}$

weak shielding

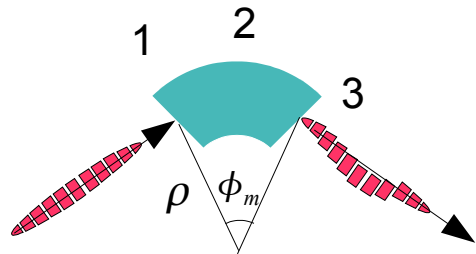
$$\rho = 25\text{m}, h = 2\text{cm}, \sigma_s = 30 \mu\text{m} (100\text{fs}) \rightarrow \eta = 0.24$$

$$\frac{P_{CSR}(\text{shielded})}{P_{CSR}(\text{free space})} = \frac{E_{loss}(\text{shielded})}{E_{loss}(\text{free space})} = 0.99$$

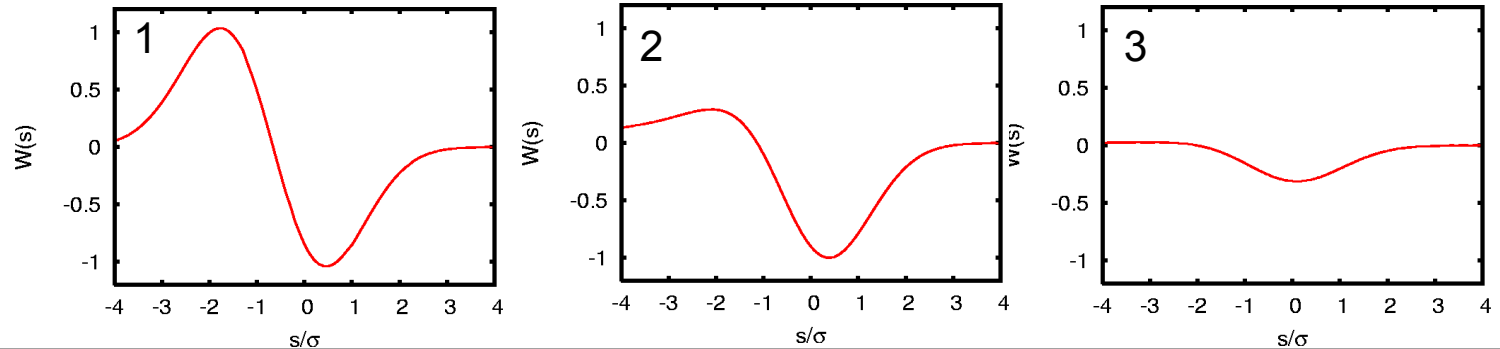
$$\frac{\Delta \varepsilon(\text{shielded})}{\Delta \varepsilon(\text{free space})} = \frac{\Delta E_{rms}(\text{shielded})}{\Delta E_{rms}(\text{free space})} = 0.99$$

Effect of Transient CSR

transient CSR



CSR wake potential shows different profile along the path.



transient CSR is neglected for

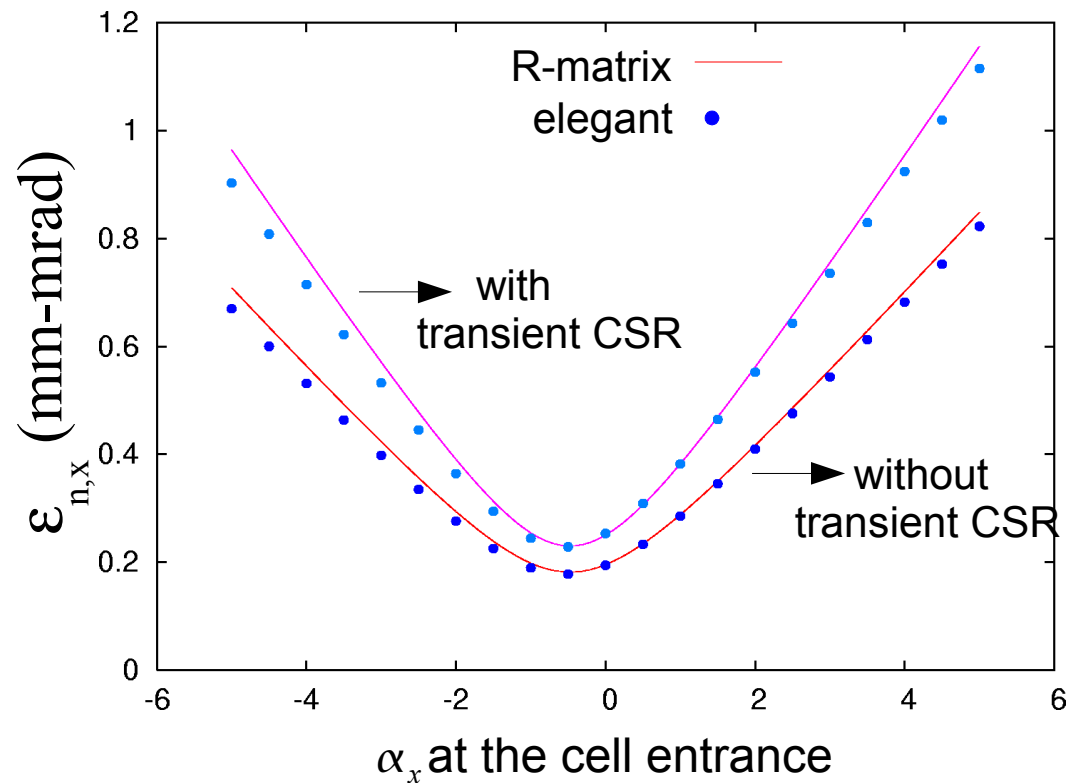
$$\rho/\gamma^3 \ll l_b \ll \rho \phi_m^3/24$$

in the 3GeV ERL,

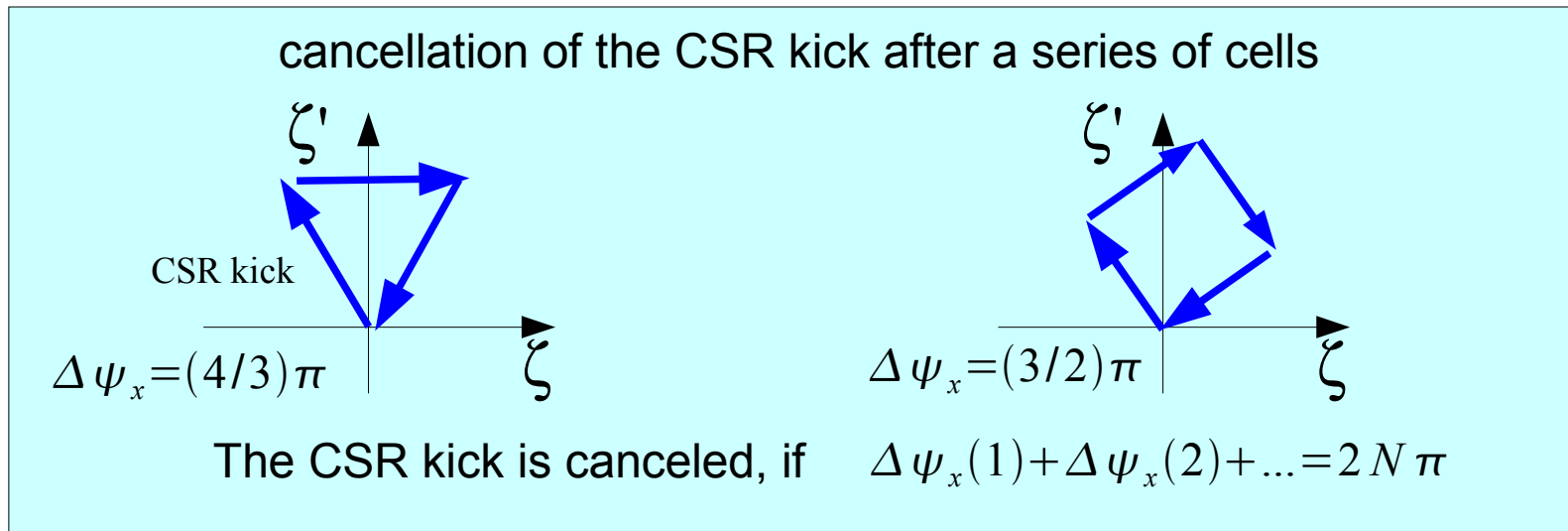
$$\rho/\gamma^3 = 1 \times 10^{-10}, \quad l_b = 3 \times 10^{-5}, \quad \rho \phi_m^3/24 = 1.5 \times 10^{-4}$$

correction of $\Delta \kappa_{rms}$ for the transient CSR

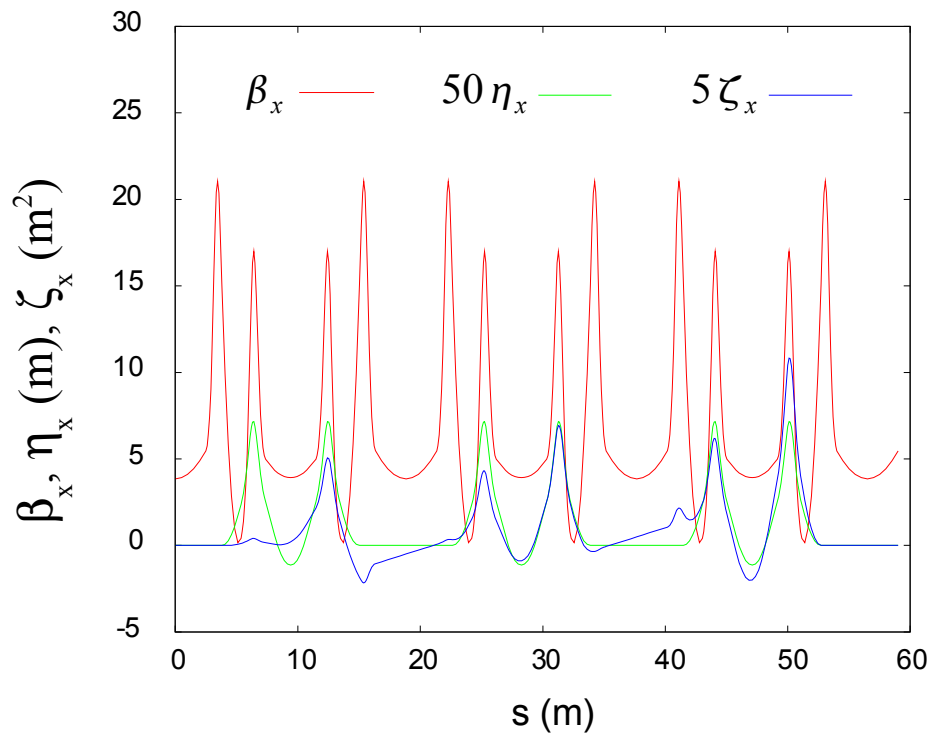
$$\Delta \kappa_{rms}^{transient} = \frac{\Delta E_{rms}^{transient}}{E_0 L_b} \quad \leftarrow \text{from elegant}$$



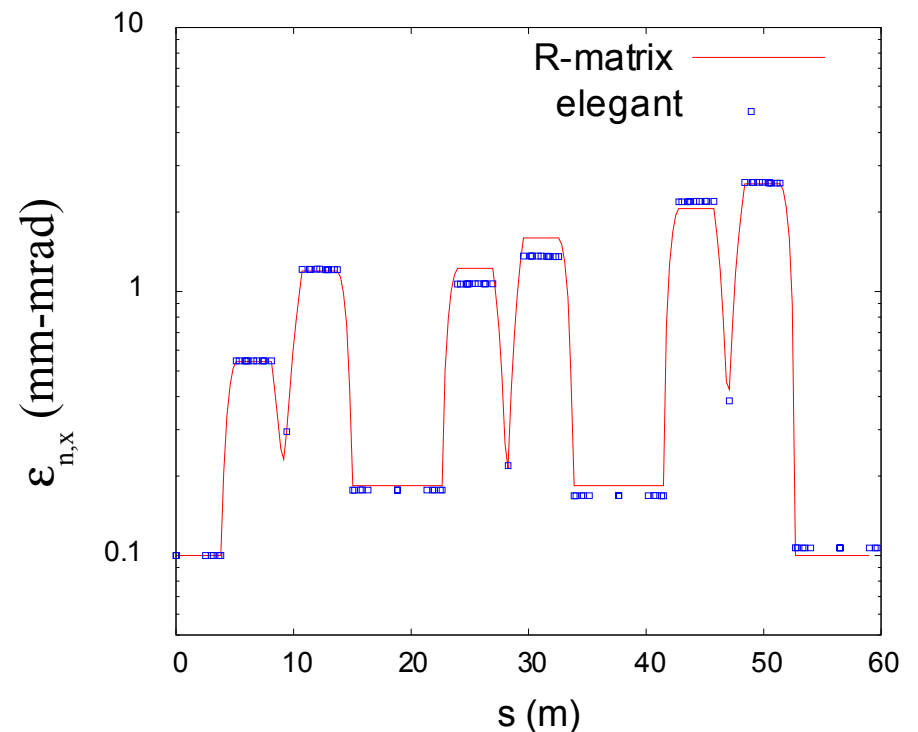
Emittance Compensation by cell-to-cell Phase Matching



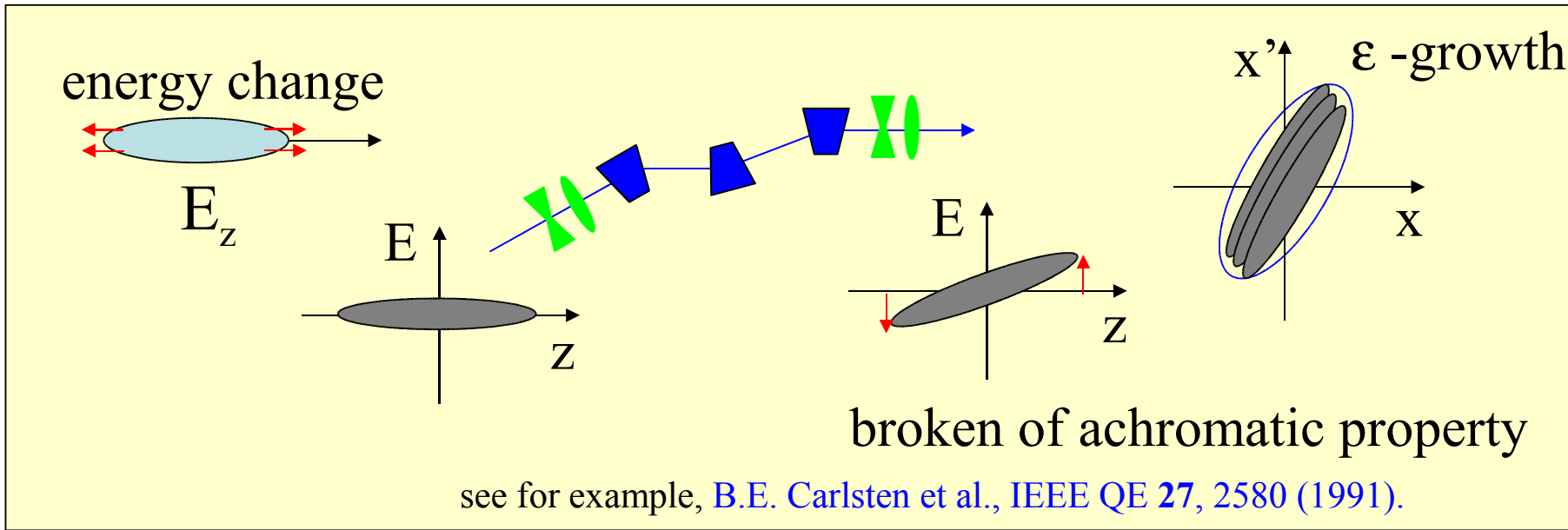
example for $\Delta \psi_x = (8/3)\pi$



emittance compensation every 3-cells



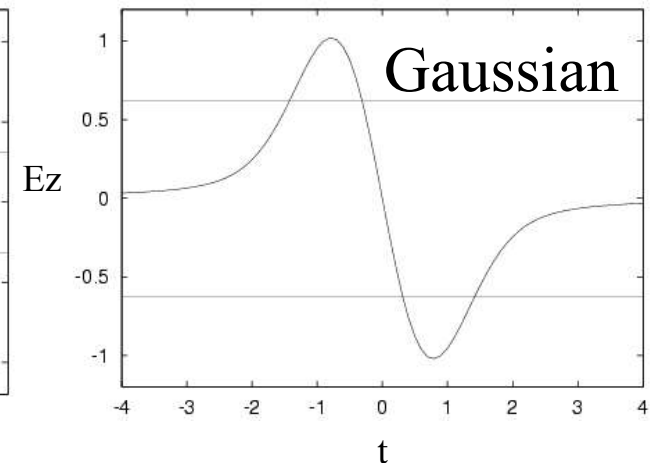
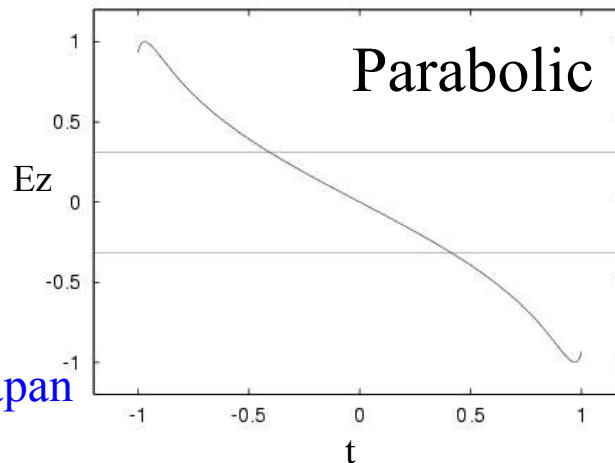
Transverse emittance growth by Ez



assuming steady-state Ez $\Delta E / E = \delta = \delta_0 + \kappa (s - s_0)$

We can track bunch slice motion by linear matrix.

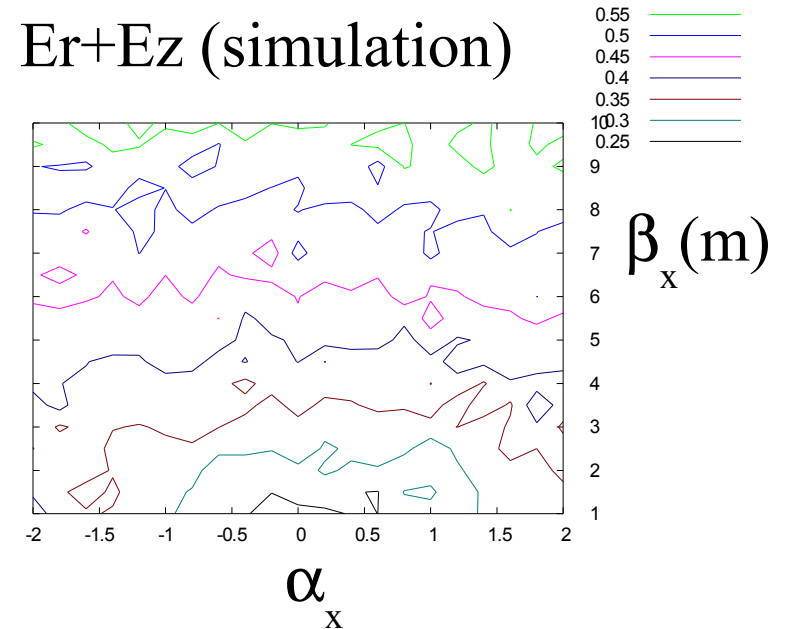
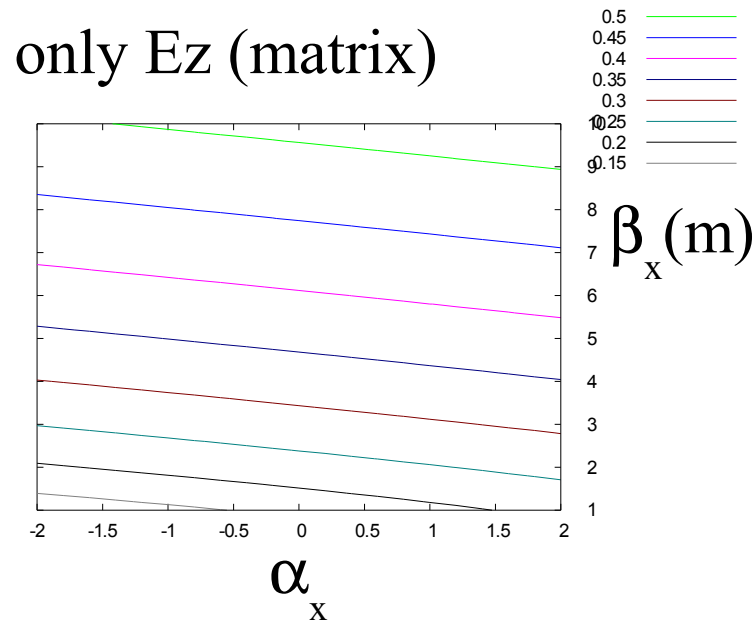
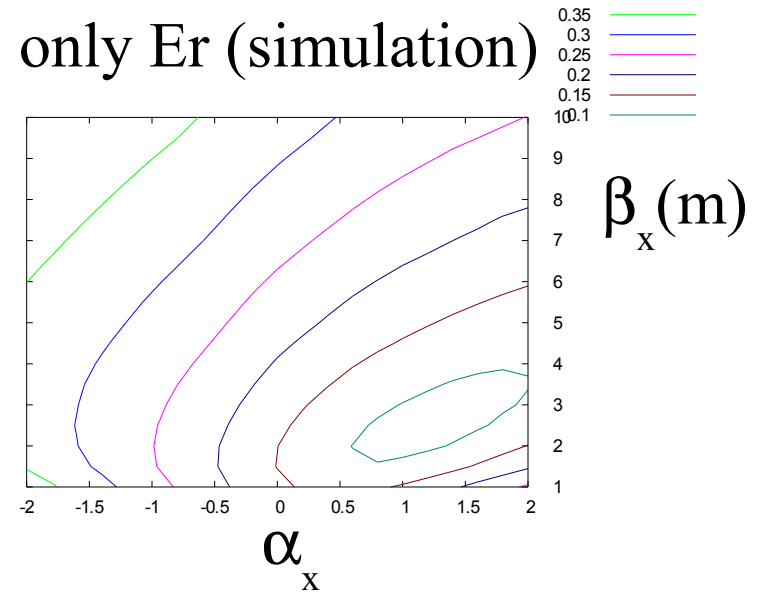
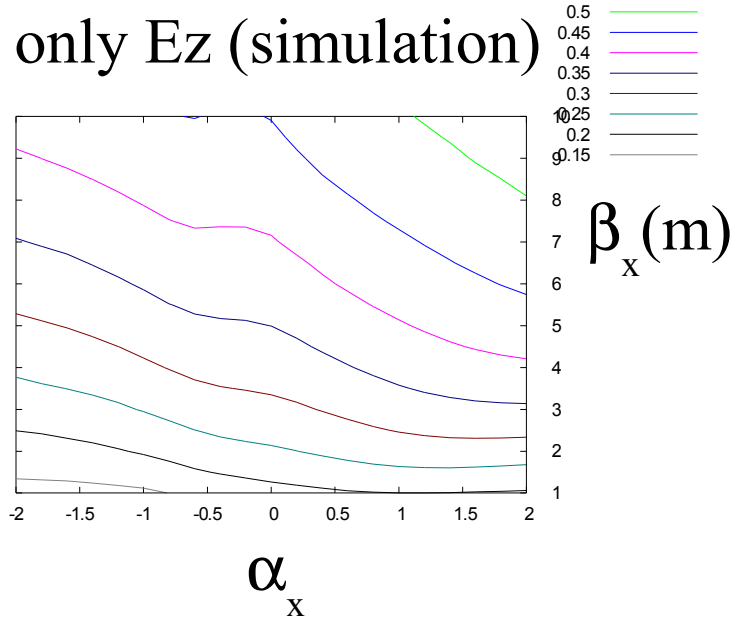
applicable to arbitrary bunch shape



R. Hajima,
Proc. Ann. Meeting of Particle Soc. Japan
p.432 (2004).

Optimum injection to a 3-dipole merger

calculate emittance growth with varying injection parameters (α_x, β_x)



Summary

- A linear analysis of beam dynamic using R-matrix is extended to the study on CSR-induced emittance growth.
- Two kind of emittance compensation techniques, "envelope matching" and "cell-to-cell phase matching" are presented.
- Emittance growth by shielded CSR and transient CSR is also discussed.
- Emittance growth by longitudinal space charge force can be calculated in a similar way.
- Results from the R-matrix analysis are compared with particle simulations. Both results show good agreement.